Search Notes		

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/616,097	SUN ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

SEARCHED			
Class	Subclass	Date Examin	
205	118	6/1/2005	EW
205	123	6/1/2005	EW
205	182	6/1/2005	EW
205	296	6/1/2005	EW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEAR((INCLUDING SE	CH NOT	ES Strategy)
		DATE	EXMR
Inventor Search		6/1/2005	EW
EAST		6/1/2005	EW
STN		6/2/2005	EW
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